

# SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS PRODUCT SPECIFICATION

規格書

**CUSTOMER :** 

DATE :

(**客戶**): 志盛翔

(日期):2019-11-20

CATEGORY (品名)	: ALUMINUM ELECTROLYTIC CAPACITORS
DESCRIPTION (型号)	: RT $400V22\mu F(\varphi 12.5X17)$
VERSION (版本)	: 01
Customer P/N	:
SUPPLIER	:

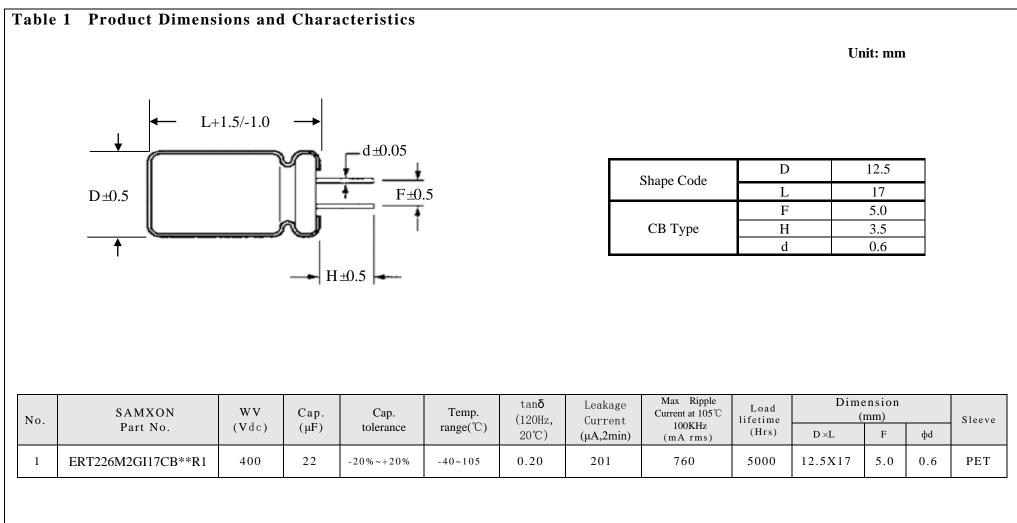
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PREPARED (拟定)	CHECKED (审核)	APPROVAL (批准)	SIGNATURE (签名)
赵安平	刘渭清		

#### ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

### SAMXON

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#### ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES



#### 1. Application

This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment. Designed capacitor's quality meets IEC60384.

#### 2. Part Number System 123 456 7 89 101112 1314 1516 17 Ρ EGS 1 0 5 м 1 H **D**1 1 TC S А SAMXON SLEEVE PRODUCT LINE MATERIAL VOLTAGE SERIES CAPACITANCE CASE SIZE TOI TYPE Feature Code Cap(MFD) Code Tolerance (%) Code Voltage (W.V.) Code Case Size SAMXON Product Lin ries ESM EKF ESS EKS 0D (d) Co 3 B 3.5 1 4 C 5 D 6.3 E For internal use only RR Radial bulk 0.1 104 ±5 J 2.5 0E (The product lines 0G 4 we have H.A.B.C.D. Ammo Taping 0.22 224 EGS 6.3 OJ EGS EKM EKG EOM EZS EGF ESF ±10 к E,M or 0,1,2,3,4,5,9) 8 0K 2.0mm Pitch τт 0.33 334 10 1A L 13 13.5 13.5 14 4.5 c 12 ±15 12.5 1B J V τυ 2.5mm Pitch 0.47 474 16 1C м +20 20 1D 3.5mm Pitch тν ESF EGT EGK EGE EGD EGC 105 Sleeve Material 1 Code 16.5 16.5 25 1E Р PET 5.0mm Pitch тс 30 11 2.2 225 Ν ±30 18.5 32 13 ERS ERF ERL ERR 35 1V Lead Cut & Form 3.3 335 -40 w ⋚ 40 1G 25 30 34 35 40 СВ-Туре СВ 42 1M 4.7 475 -20 0 ERT ERE ERD ERH EBD А 50 1H СЕ-Туре CE 10 106 57 1L -20 +10 63 **1**J С <u>42</u> 45 HE HE-Type 22 226 71 15 40 51 63.5 76 80 90 100 ERA ERB ERC EFA -20 +40 75 1**T** x KD-Type KD 33 336 80 1K 85 1R -20 +50 FD-Type FD s 476 ENH ERW ERY ELP EAP 47 90 19 Code 45 54 57 77 72 112 118 12 18 12 25 20 20 30 34 35 35 100 2A 4.5 -10 EH-Type EH в 100 107 120 20 5.4 125 2B PCB Termial $\begin{array}{r} 7\\ \hline 7.7\\ \hline 10.2\\ \hline 11\\ \hline 11.5\\ \hline 12\\ \hline 2.5\\ \hline 13\\ \hline \\ 13\\ \hline \end{array}$ -10 +20 227 220 EQP EDP v 150 2Z 160 2C sw ETP EHP EUP 337 330 -10 +30 180 2P Q 2D 200 Snap-in sx EKP EEP EFP ESP EVP 470 477 -10 +50 215 22 т 220 2N 13.5 sz 2200 228 -5 +10 230 23 20 25 29.5 Е 250 2E Lug SG 22000 229 275 2Т 30 31.5 35 35.5 -5 +15 F 300 21 05 35.5 50 80 100 105 110 120 30 40 33000 339 310 2R -5 +20 G 50 80 1L 1M 1N 1P 06 2F 315 EWS EWH EWL EWB VSS 47000 479 2U 330 0 +20 R 350 Т5 2V 10T 100000 Screw 2X 0 +30 360 0 т6 VNS 375 2Q 150000 15T VKS VKM VRL VNH 10 1R 1E 2Y 40 50 385 +50 Т D5 400 2G 220000 22T 15 1F 1T +5 +15 z 420 2M D6 450 2W VRF 330000 33T +5 D 500 2H 550 25 1000000 10M +10+50 Y 600 26 630 2J 1500000 15M +10 +30 н 2200000 22M 3300000 33M 5

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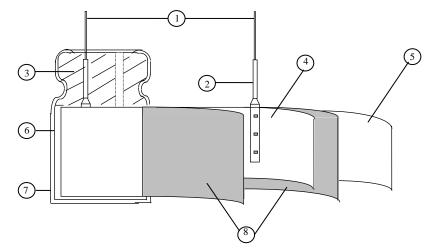
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#### ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES

## SAMXON

#### 3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



No	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	PET
8	Separator	Electrolyte paper

#### 4. Characteristics

#### Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature	:15°C to 35°C
Relative humidity	: 45% to 85%
Air Pressure	: 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature	$: 20^{\circ}C \pm 2^{\circ}C$
Relative humidity	: 60% to 70%
Air Pressure	: 86kPa to 106kPa

#### Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

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Tabl	ITEM				PE	RFORM	IANCE					
	Rated voltage (WV)											
4.1		WV (V.DC)	160	200	220	250	350	400	420	450		
	Surge voltage (SV)	SV (V.DC)	200	250	270	300	400	450	470	500		
4.2	Nominal capacitance (Tolerance)	Measuring F Measuring V Measuring T <criteria></criteria>	Shall be within the specified capacitance tolerance.									
4.3	Leakage current	<b><condition></condition></b> Connecting the capacitor with a protective resistor $(1k\Omega \pm 10\Omega)$ in series for 2 minutes, and then, measure Leakage Current. <b><criteria></criteria></b> Refer to Table 1										
4.4	tanδ	<condition> See 4.2, Norm Capacitance, for measuring frequency, voltage and temperature. <criteria> Refer to Table 1</criteria></condition>										
4.5	Terminal strength	0.51	ength c capacito apacito 2~3 sec ter of le mm anc	or, appl of Term r, applie conds, a ead wire	ied force and force and then	to bent bent it Fensile (kg	the terr for $90^{\circ}$ force N (f) (.51)	ninal (1 ' to its c	~4 mm original Bendin (k 2.5	from th	e rubber) 1 1 within 2	
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		2	-40(-2			Time to reach thermal equilibrium Time to reach thermal equilibrium				-
		3	20			Time to reach thermal equilibrium				_
		4	105				ach therm	-		_
		5	20				ach therm			_
		<criteria></criteria>	20	<u> </u>	11			iai equili	Ullulli	
			°C, capacitance r	nageurad	l chall ba	within +	- 20%			
	Temperature		iginal value at +2			within <u>-</u>	_ 20 /0			
1.6	characteristi		hall be within the		Ttem 4.4					
	cs		age current meas				8 times of	f its spec	ified va	lue.
			5, $tan\delta$ shall be					1		
			eakage current sh			-				
			C, impedance (Z)	) ratio sh	all not ex	ceed the	value of	the follo	wing	
		table:								
		Worki	ng Voltage (V)	160	200	250	350	400	450	٦
		Z-2.	5°C/Z-+20°C	3	3	3	5	5	6	
		Capacita	ince, $tan\delta$ , and i	impedan	ce shall b	e measu	red at 120	OHz.		
		~ ~ ~ ~								
		<condition></condition>		4 13 met	thods Th	e canacit	or is stor	ed at a te	mperatu	ire o
		According to	IEC60384-4No.			-			-	
		According to 105 ℃ ±2 w	IEC60384-4No. ith DC bias volta	ige plus t	the rated 1	ripple cu	rrent for '	Table 1.	(The su	ım c
		According to 105 ℃ ±2 w DC and ripp	IEC60384-4No.	ige plus t shall no	the rated i ot exceed	ripple cur the rate	rrent for ' d workir	Table 1.	(The su ge) The	um o n th
	Load	According to $105 \ \ \pm 2 \ w$ DC and ripp product shoul result should	IEC60384-4No. ith DC bias volta le peak voltage	ige plus t shall no 16 hours	the rated i ot exceed s recoveri	ripple cur the rate	rrent for ' d workir	Table 1.	(The su ge) The	um o n th
4.7	life	According to 105 ℃ ±2 w DC and ripp product shou result should < <b>Criteria</b> >	IEC60384-4No. ith DC bias volta le peak voltage ld be tested after meet the followi	ige plus t shall no 16 hours ing table	the rated 1 ot exceed s recoveri :	the rate	rrent for ' d workir at atmosp	Table 1.	(The su ge) The	um o n th
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4.7	life	According to $105 \ C \pm 2 \ w$ DC and ripp product shoul crisult should criteria> The character Leaka Capac	IEC60384-4No. ith DC bias volta le peak voltage ld be tested after meet the followi	ige plus t shall no 16 hours ing table the follo Value Withi	the rated 1 of exceed s recoveri : wing require in $4.3$ sh in $\pm 20\%$	ripple cur the rate ng time a <u>uirement</u> nall be sa of initia	rrent for ' d workir at atmosp s. tisfied al value.	Table 1. ng voltag heric con	(The suge) Then ditions	um o n th
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	Shelf life	According to $105 \ C \pm 2 \ W$ DC and ripp product should <b><criteria></criteria></b> The character Leaka Capace tan $\delta$ Appea <b><condition:< b=""> The capacitors <math>1000+48/0 \ h</math> chamber and shall be coma applied for 3</condition:<></b>	IEC60384-4No. ith DC bias volta le peak voltage ld be tested after meet the following cristic shall meet ge current itance Change arance are then stored voltage be allowed to s nected to a serie Omin. After whic	ege plus t shall no 16 hours ing table the follo Value Withi Not n There with no v this perio tabilized s limitin	the rated i of exceed s recoveri : $\frac{1}{20\%}$ nore than e shall be voltage ap od the cap i at room ig resistor	ripple cur the rate ng time a uirement nall be sa of initia 200% of no leaka oplied at pacitors a tempera $r(1k \pm 10$	rrent for ' d workin at atmosp s. tisfied al value. f the spec ge of ele a temper shall be r ture for $4$ $00\Omega$ ) wit	Table 1. ng voltag heric con cified val ctrolyte. ature of 1 emoved 4~8 hour h D.C. r	(The suge) Then inditions ue. $05\pm 2^{\circ}$ from the s. Next ated vo	um o n th . Th C fo e tes the lltag
	Shelf life	According to $105 \ C \pm 2 \ W$ DC and ripp product should <b><criteria></criteria></b> The character Leaka Capace tan $\delta$ Appea <b><condition:< b=""> The capacitors <math>1000+48/0 \ h</math> chamber and shall be coma applied for 3</condition:<></b>	IEC60384-4No. ith DC bias volta le peak voltage ld be tested after meet the following cristic shall meet ge current itance Change arance are then stored voltage be allowed to s nected to a serie Omin. After whic	ege plus t shall no 16 hours ing table the follo Value Withi Not n There with no v this perio tabilized s limitin	the rated i of exceed s recoveri : $\frac{1}{20\%}$ nore than e shall be voltage ap od the cap i at room ig resistor	ripple cur the rate ng time a uirement nall be sa of initia 200% of no leaka oplied at pacitors a tempera $r(1k \pm 10$	rrent for ' d workin at atmosp s. tisfied al value. f the spec ge of ele a temper shall be r ture for $4$ $00\Omega$ ) wit	Table 1. ng voltag heric con cified val ctrolyte. ature of 1 emoved 4~8 hour h D.C. r	(The suge) Then inditions ue. $05\pm 2^{\circ}$ from the s. Next ated vo	um o n th . Th C fo e tes the lltag
	Shelf life	According to $105 \ C \pm 2 \ W$ DC and ripp product should <b><criteria></criteria></b> The character Leaka Capace tan $\delta$ Appea <b><condition:< b=""> The capacitors <math>1000+48/0 \ h</math> chamber and shall be coma applied for 3</condition:<></b>	IEC60384-4No. ith DC bias volta le peak voltage ld be tested after meet the following cristic shall meet ge current itance Change arance are then stored voltage be allowed to s nected to a serie Omin. After whic	ege plus t shall no 16 hours ing table the follo Value Withi Not n There with no v this perio tabilized s limitin	the rated i of exceed s recoveri : $\frac{1}{20\%}$ nore than e shall be voltage ap od the cap i at room ig resistor	ripple cur the rate ng time a uirement nall be sa of initia 200% of no leaka oplied at pacitors a tempera $r(1k \pm 10$	rrent for ' d workin at atmosp s. tisfied al value. f the spec ge of ele a temper shall be r ture for $4$ $00\Omega$ ) wit	Table 1. ng voltag heric con cified val ctrolyte. ature of 1 emoved 4~8 hour h D.C. r	(The suge) Then inditions ue. $05\pm 2^{\circ}$ from the s. Next ated vo	um o n th . Th C fo e tes the lltag

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## SAMXON

		<criteria></criteria>	most the fellowing requirements
			Walue in 4.3 shall be satisfied
	Shelf	Leakage current	
4.8	life	Capacitance Change	Within $\pm 20\%$ of initial value.
	test	tanδ	Not more than 200% of the specified value.
		Appearance	There shall be no leakage of electrolyte.
		-	e stored more than 1 year, the leakage current may
			the through about 1 k $\Omega$ resistor, if necessary.
4.9	Surge		be 15~35°C.
1.2	test	Capacitance Change	Within $\pm 15\%$ of initial value.
		tanð	Not more than the specified value.
		Appearance	There shall be no leakage of electrolyte.
		Attention:	There shall be no leakage of electrolyte.
		This test simulates over volta over voltage as often applied <condition></condition>	age at abnormal situation only. It is not applicable to such d.
4.10	Vibration test	perpendicular directions. Vibration frequency r Peak to peak amplitud Sweep rate Mounting method:	e : 1.5mm : 10Hz ~ 55Hz ~ 10Hz in about 1 minute greater than 12.5mm or longer than 25mm must be fixed or less Within 30°
		<criteria> After the test, the follow Inner construction</criteria>	To be soldered ring items shall be tested: No intermittent contacts, open or short circuiting. No damage of tab terminals or

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-					
		<condition></condition>			
		The capacitor shall be test	-	conditions:	
		Soldering temperature	: 245±3°C		
	0 11 1 12	Dipping depth	: 2mm		
4.11	Solderability	Dipping speed	: 25±2.5mm	u/s	
	test	Dipping time	: 3±0.5s		
		<criteria></criteria>		<u> </u>	1 .
		Coating quality	immersed	n of 95% of the surfac	ce being
			minerseu		
		<condition></condition>			
		Terminals of the capac	itor shall be immersed i	nto solder bath at	
		$260\pm5$ °C for $10\pm1$ seco			mm from the
				-0 50001105 105 2.0	
	Directory	body of capacitor . Then the capacitor shall	ll be left under the norn	nal temperature and n	ormal
4.12	Resistance to solder heat	humidity for 1~2 hours		har temperature and h	ormar
4.12	test	<criteria></criteria>			
	test	Leakage current	Not more than the	specified value.	
		Capacitance Change	Within $\pm 10\%$ of		
		tanδ	Not more than the	specified value.	
		Appearance	There shall be no l	eakage of electrolyte	•
		<condition></condition>			
		Temperature Cycle:			
		the condition according	4-4No.4.7methods, capa	acitor shall be placed	in an oven,
			mperature	Time	1
		(1)+20°C	Inperature	1	
					-
	Change of	(2)Rated low tempera		$30\pm 2$ Minutes	-
4.13	temperature	(3)Rated high temperative		$30\pm2$ Minutes	-
	test	(1) to (3)=1 cycle, tot	al 5 cycle		
		<criteria></criteria>			
			l meet the following real		٦ I
		Leakage current	Not more than the s	-	-
		tanδ	Not more than the s	•	-
		Appearance	There shall be no le	akage of electrolyte.	
		<condition></condition>			
		Humidity Test:			
		According to IEC60384	-		
		be exposed for $500\pm8$ k	-		
	5 1	$40\pm2^{\circ}$ C, the characteris	stic change shall meet the	he following requirer	nent.
4.14	Damp heat	<criteria></criteria>			_
	test	Leakage current	Not more than the spe		
		Capacitance Change	Within $\pm 20\%$ of init		
		tanδ	Not more than 120% of	of the specified value	
		Appearance	There shall be no leak	age of electrolyte.	
I	•				

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Condition> The maximum permissible ripple current is the maximum A.C current at 120Hz and can be applied at maximum operating temperature Table-1 The combined value of D.C voltage and the peak A.C voltage shall not exe rated voltage and shall not reverse voltage. Frequency Multipliers:	
4.16 Maximum permissible (ripple current) $1 - 5.6$ $0.20$ $0.40$ $0.80$ $1.00$ 6.8 - 180 $0.40$ $0.75$ $0.90$ $1.00220 - 0.50$ $0.85$ $0.94$ $1.00$	ceed the

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#### ELECTROLYTIC CAPACITOR SPECIFICATION RT SERIES



# **5.** It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances					
	Cadmium and cadmium compounds					
Heavy metals	Lead and lead compounds					
Heavy metals	Mercury and mercury compounds					
	Hexavalent chromium compounds					
	Polychlorinated biphenyls (PCB)					
Chloinated	Polychlorinated naphthalenes (PCN)					
organic	Polychlorinated terphenyls (PCT)					
compounds	Short-chain chlorinated paraffins(SCCP)					
	Other chlorinated organic compounds					
	Polybrominated biphenyls (PBB)					
Brominated organic	Polybrominated diphenylethers(PBDE) (including					
	decabromodiphenyl ether[DecaBDE])					
compounds	Other brominated organic compounds					
Tributyltin comp	ounds(TBT)					
Triphenyltin com	apounds(TPT)					
Asbestos						
Specific azo com	pounds					
Formaldehyde						
Beryllium oxide						
Beryllium copp	er					
Specific phthalat	es (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)					
Hydrofluorocarb	on (HFC), Perfluorocarbon (PFC)					
Perfluorooctane	sulfonates (PFOS)					
Specific Benzotr	iazole					

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RT SERIES
<ul> <li>(6) Wiring Near the Pressure Relief Vent Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite.</li> <li>(7) Circuit Board patterns Under the Capacitor Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short.</li> <li>(8) Screw Terminal Capacitor Mounting Do not orient the capacitor with the screw terminal side of the capacitor facing downwards. Tighten the terminal and mounting bracket screws within the torque range specified in the specification.</li> </ul>
<ol> <li>Electrical Isolation of the Capacitor Completely isolate the capacitor as follows.</li> <li>Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths</li> <li>Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths.</li> </ol>
1.7 The Product endurance should take the sample as the standard.
1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling.
<ul> <li>Capacitor Sleeve         The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor.         The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures.     </li> </ul>
CAUTION! Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use. (1) Provide protection circuits and protection devices to allow safe failure modes. (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure.
<ul> <li>2.Capacitor Handling Techniques</li> <li>2.1 Considerations Before Using <ol> <li>Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment.</li> <li>Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about 1kΩ.</li> <li>Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately 1kΩ.</li> <li>If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors.</li> <li>Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result.</li> </ol> </li> </ul>
<ul> <li>2.2 Capacitor Insertion <ol> <li>Verify the correct capacitance and rated voltage of the capacitor.</li> <li>Verify the correct polarity of the capacitor before inserting.</li> <li>Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals.</li> <li>Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor.</li> <li>For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection.</li> </ol> </li> </ul>
<ul> <li>2.3 Manual Soldering</li> <li>(1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less.</li> <li>(2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal.</li> <li>(3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads.</li> <li>(4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve.</li> </ul>
2.4 Flow Soldering

- (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result.
- (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.
- (3) Do not allow other parts or components to touch the capacitor during soldering.
- 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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2.6 Capacitor Handling after Solder

- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.
- 2.7 Circuit Board Cleaning

Acetone

- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

- Alkali solvents : could attack and dissolve the aluminum case.
- Petroleum based solvents: deterioration of the rubber seal could result. Xylene
  - : deterioration of the rubber seal could result.
    - : removal of the ink markings on the vinvl sleeve could result.
- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.

2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

#### 3. Precautions for using capacitors

3.1 Environmental Conditions

- Capacitors should not be stored or used in the following environments.
- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

**3.2 Electrical Precautions** 

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

#### 4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures.

If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.

If electrolyte or gas is ingested by month, gargle with water.

If electrolyte contacts the skin, wash with soap and water.

#### 5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a  $1000\Omega$ , current limiting resistor for a time period of 30 minutes. If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions

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The capacitor shall be not use in the following condition:

(1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.

(2) Direct contact with water, salt water, or oil.

(3) High humidity conditions where water could condense on the capacitor.

(4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.

(5) Exposure to ozone, radiation, or ultraviolet rays.

(6) Vibration and shock conditions exceeding specified requirements.

#### 6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the

polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.

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